


<b>Search Notes</b>  	<b>Application/Control No.</b>  10804722	<b>Applicant(s)/Patent Under Reexamination</b>  CHOI ET AL.
	<b>Examiner</b>  Mandeville, Jason M	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	76-84, 690, 694-695	17 October 2007	Jason Mandeville
313	483-512	17 October 2007	Jason Mandeville
315	169.1-169.3	17 October 2007	Jason Mandeville
345	76-84, 690, 694-695	16 April 2008	Jason Mandeville
313	483-512	16 April 2008	Jason Mandeville
315	169.1-169.3	16 April 2008	Jason Mandeville
345	76-78, 82-84, 87-89, 690, 694-695	11/04/2008	Jason Mandeville
313	483-512	11/04/2008	Jason Mandeville
315	169.1-169.3	11/04/2008	Jason Mandeville

SEARCH NOTES		
Search Notes	Date	Examiner
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	17 October 2007	Jason Mandeville
Inventor Search	17 October 2007	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	16 April 2008	Jason Mandeville
Inventor Search	16 April 2008	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	11/04/2008	Jason Mandeville
Inventor Search	11/04/2008	Jason Mandeville

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<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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